## Reexamination 10/659,388 PARK, KYUNG CHAN Notice of References Cited Examiner Art Unit

Application/Control No.

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Applicant(s)/Patent Under

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0001274	01-2002	Nakajima et al.	369/53.21
*	В	US-2002/0054555	05-2002	Karakawa et al.	369/53.33
*	C	US-5,737,284	04-1998	Yamada, Minoru	369/30.04
*	D	US-6,243,336	06-2001	Schell et al.	369/44.29
*	F	US-5,862,123	01-1999	Horie et al.	369/275.4
*	F	US-6,128,272	10-2000	Horimai et al.	369/44.26
*	G	US-6,125,181	09-2000	Gotoh et al.	380/2
	Η	US-			
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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